

Si1433DH

**Vishay Siliconix** 

# P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	r <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A)		
- 30	0.150 at V <sub>GS</sub> = - 10 V	- 2.2		
	0.260 at V <sub>GS</sub> = - 4.5 V	- 1.6		

### FEATURES

- TrenchFET<sup>®</sup> Power MOSFETS: 1.8 V Rated
- Thermally Enhanced SC-70 Package

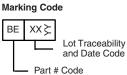
### APPLICATIONS

- Load Switches
  - Notebook PC
  - Servers



COMPLIANT

# SOT-363 SC-70 (6-LEADS) D 1 6 D D 2 5 D G 3 4 S Top View



Ordering Information: Si1433DH-T1 Si1433DH-T1-E3 (Lead (Pb)-free)

ABSOLUTE MAXIMUM RATINGS	<sub>A</sub> = 25 °C, unle	ess otherwise	noted			
Parameter		Symbol	5 s	Steady State	Unit	
Drain-Source Voltage		V <sub>DS</sub>	- 30		v	
Gate-Source Voltage		V <sub>GS</sub>	± 20			
Continuous Drain Qurrent (T 150 °C)	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	- 2.2	- 1.9		
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup>	T <sub>A</sub> = 85 °C		- 1.7	- 1.4	^	
Pulsed Drain Current		I <sub>DM</sub>	- 8		A	
Continuous Diode Current (Diode Conduction) <sup>a</sup>		۱ <sub>S</sub>	- 1.4	- 0.9	1	
Marian Dissistive	T <sub>A</sub> = 25 °C	- P <sub>D</sub>	1.45	0.95	W	
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> = 85 °C		0.75	0.5		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150		°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Mauinum lunchian ta Ambianta	t ≤ 5 s	- R <sub>thJA</sub> R <sub>thJF</sub>	65	85	
Maximum Junction-to-Ambient <sup>a</sup>	Steady State		105	130	°C/W
Maximum Junction-to-Foot (Drain)	Steady State		38	48	

Notes:

a. Surface Mounted on 1" x 1" FR4 Board.

\* Pb containing terminations are not RoHS compliant, exemptions may apply.



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Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit	
Static				•	•		
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -100 \ \mu A$	- 1		- 3	V	
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 8 V$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 16 V, V <sub>GS</sub> = 0 V			- 1		
		$V_{DS}$ = - 16 V, $V_{GS}$ = 0 V, $T_{J}$ = 85 °C			- 5	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} = -5 V, V_{GS} = -4.5 V$ - 4				Α	
Drain-Source On-State Resistance <sup>a</sup>	r <sub>DS(on)</sub>	$V_{GS} = -10$ V, $I_{D} = -2.2$ A		0.120	0.150	0	
		V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 1.6 A		0.210	0.260	Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 2.2 A		4		S	
Diode Forward Voltage <sup>a</sup>	V <sub>SD</sub>	I <sub>S</sub> = - 1.2 A, V <sub>GS</sub> = 0 V		- 0.85	- 1.2	V	
Dynamic <sup>b</sup>	•			•			
Total Gate Charge	Qg			3.1	5	nC	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = - 15 V, $V_{GS}$ = - 4.5 V, $I_{D}$ = - 2.2 A		1.0			
Gate-Drain Charge	Q <sub>gd</sub>			1.6			
Turn-On Delay Time	t <sub>d(on)</sub>			11	17		
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, $R_L$ = 15 $\Omega$		17	26	1	
Turn-Off Delay Time	t <sub>d(off)</sub>	$\text{I}_{\text{D}}\cong$ - 1 A, $\text{V}_{\text{GEN}}$ = - 10 V, $\text{R}_{\text{G}}$ = 6 $\Omega$		18	27	- ns	
Fall Time	t <sub>f</sub>			13	20		

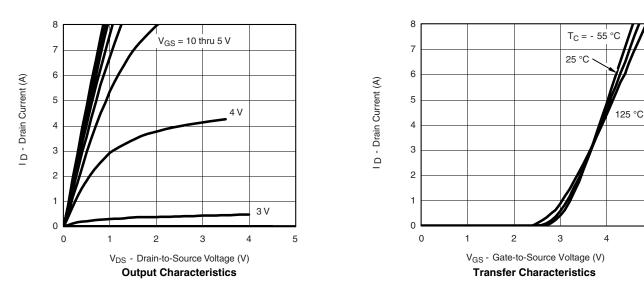
Notes:

a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



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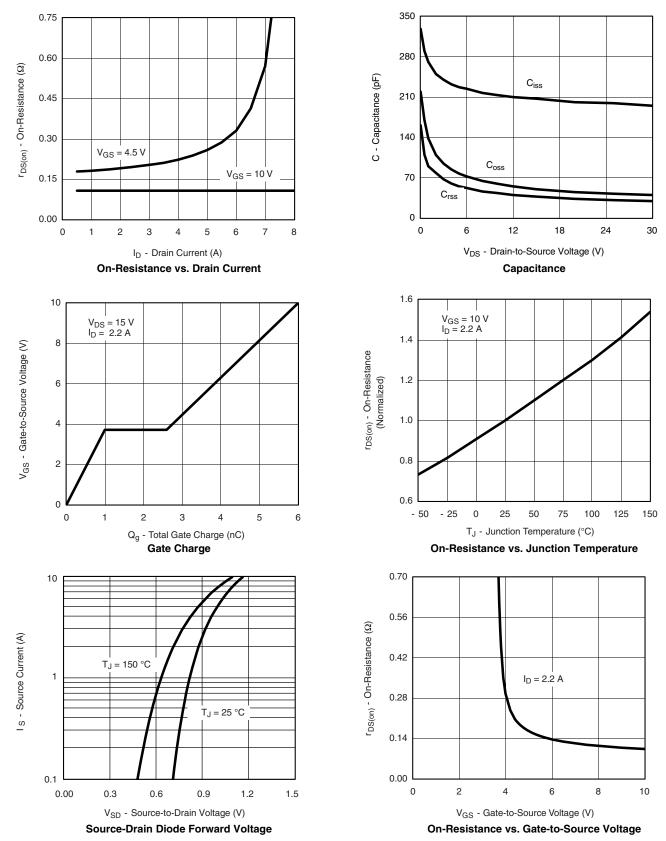




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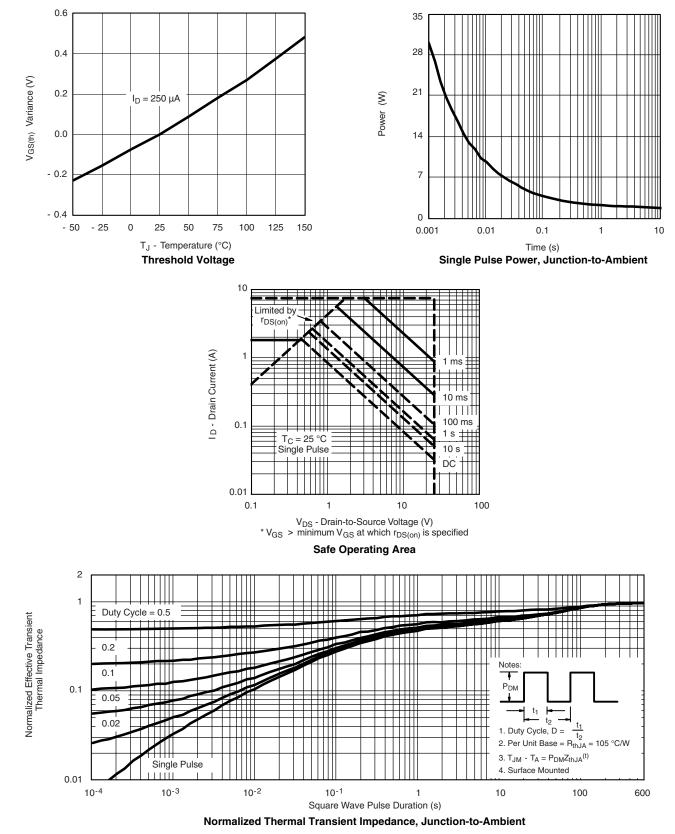
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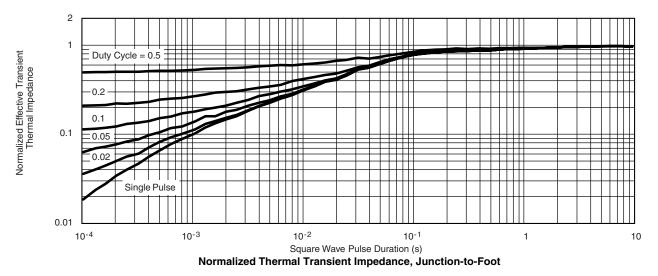




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